	TEST REP	ORI				
FCC ID	2ALNA-BTS33P	ALNA-BTS33P				
Test Report No:	TCT250113E006					
Date of issue:	Jan. 17, 2025					
Testing laboratory:	SHENZHEN TONGCE T	ESTING LA	3			
Testing location/ address:	2101 & 2201, Zhenchang Factory, Renshan Industrial Zone, Fuhai Subdistrict, Bao'an District, Shenzhen, Guangdong, 518103, People's Republic of China					
Applicant's name:	Shenzhen Thousandsho	res Technolo	ogy Co., Ltd.			
Address:	Room 1101, Building B, Lotus Plaza, No. 3186, Nanshan Avenue, Majialong Community, Nantou Street, Nanshan District, Shenzhen, China					
Manufacturer's name :	Shenzhen Thousandsho	res Technolo	ogy Co., Ltd.			
Address:	Room 1101, Building B, Lotus Plaza, No. 3186, Nanshan Avenue, Majialong Community, Nantou Street, Nanshan District, Shenzhen, China					
Standard(s):	KDB 447498 D01 General RF Exposure Guidance v06					
Product Name:	Portable Wireless Speaker					
Trade Mark:	Tribit	Tribit C				
Model/Type reference:	BTS33					
Rating(s):	Rechargeable Li-ion Batt	tery DC 3.7V				
Date of receipt of test item	Jan. 13, 2025					
Date (s) of performance of test:	Jan. 13, 2025 ~ Jan. 17, 2025					
Tested by (+signature) :	Rleo LIU	R	LO LUXONGCE			
Check by (+signature) :	Beryl ZHAO	Bay	TCT) TING		
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1. General Product Information

1.1. EUT description

Product Name:	Portable Wireless Speaker
Model/Type reference:	BTS33
Sample Number:	TCT250113E005-0101
Operation Frequency:	2402MHz~2480MHz
Modulation Type:	GFSK, π/4-DQPSK, 8DPSK
Antenna Type:	PCB Antenna
Antenna Gain:	0dBi
Rating(s):	Rechargeable Li-ion Battery DC 3.7V

Note: The antenna gain listed in this report is provided by applicant, and the test laboratory is not responsible for this parameter.



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2. General Information

2.1. Test environment and mode

ltem	Normal condition				
Temperature		+25°C			
Voltage		DC 3.7V			
Humidity		56%			
Atmospheric Pressure:	(c^{\prime})	1008 mbar		(C	
Test Mode:					
Engineering mode:	Keep the EUT in continuous transmitting by select channel				

2.2. Description of Support Units

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Equipment	Model No.	Serial No.	FCC ID	Trade Name
1		L	1	1
Matar				

Note:

- 1. All the equipment/cables were placed in the worst-case configuration to maximize the emission during the test.
- 2. Grounding was established in accordance with the manufacturer's requirements and conditions for the intended use.
- 3. For conducted measurements (Output Power, 20dB Occupied Bandwidth, Carrier Frequencies Separation, Hopping Channel Number, Dwell Time, Spurious Emissions), the antenna of EUT is connected to the test equipment via temporary antenna connector, the antenna connector is soldered on the antenna port of EUT, and the temporary antenna connector is listed in the Test Instruments.

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3. Facilities and Accreditations

3.1. Facilities

The test facility is recognized, certified, or accredited by the following organizations:

• FCC - Registration No.: 645098

SHENZHEN TONGCE TESTING LAB

Designation Number: CN1205

The testing lab has been registered and fully described in a report with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files.

- IC Registration No.: 10668A
- SHENZHEN TONGCE TESTING LAB
- CAB identifier: CN0031

The testing lab has been registered by Innovation, Science and Economic Development Canada for radio equipment testing.

3.2. Location

SHENZHEN TONGCE TESTING LAB

Address: 2101 & 2201, Zhenchang Factory, Renshan Industrial Zone, Fuhai Subdistrict, Bao'an District, Shenzhen, Guangdong, 518103, People's Republic of China TEL: +86-755-27673339

4. Test Results and Measurement Data

According to KDB 447498 D01 General RF Exposure Guidance v06, systems operating under the provisions of this section shall be operated in a manner that ensures that the public is not exposed to radio frequency energy level in excess of the commission's guidance.

The 1-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances ≤ 50 mm are determined by:

[(max. power of channel, including tune-up tolerance, mW) / (min. test separation distance, mm)] $\cdot [\sqrt{f}(GHz)] \le 3.0$ for 1-g SAR, where

- f(GHz) is the RF channel transmit frequency in GHz
- Power and distance are rounded to the nearest mW and mm before calculation When the minimum test separation distance is < 5 mm, a distance of 5 mm
 - according is applied to determine SAR test exclusion.
- The result is rounded to one decimal place for comparison
- BDR+EDR:

Channel	Frequency (GHz)	Max. Power (dBm)	Tune up Power (dBm)	Max. Tune up Power (dBm)	Max. Tune up Power (mW)	Test distance (mm)	Result	exclusion thresholds for 1-g SAR	
CH 39	2.441	5.15	5±1	6	3.98	5	1.24	3.0	

Result:

Base on the calculation value, No SAR measurement is required.

*****END OF REPORT